

11mΩ, 150V, N-Channel Power MOSFET
SRT15N110H
General Description

The Sanrise SRT15N110H is a low voltage power MOSFET, fabricated using advanced split gate trench technology. The resulting device has extremely low on resistance, low gate charge and fast switching time, making it especially suitable for applications which require superior power density and synchronous rectification.

The SRT15N110H break down voltage is 150V and it has a high rugged avalanche characteristics. The SRT15N110H is available in PDFN5*6 and TO-220C packages.

Features

- Ultra Low
 $R_{DS(ON)_{TYP}} = 9.1m\Omega$, PDFN5*6 @ $V_{GS} = 10V$.
 $R_{DS(ON)_{TYP}} = 10.3m\Omega$, TO-220C @ $V_{GS} = 10V$.
- Ultra Low Gate Charge, $Q_g=40nC$ typ.
- Fast switching capability
- Robust design with better EAS performance
- EMI Improved
- Non-automotive Qualified

Application

- Server/Telecom
- High Power Supply
- Solar
- UPS

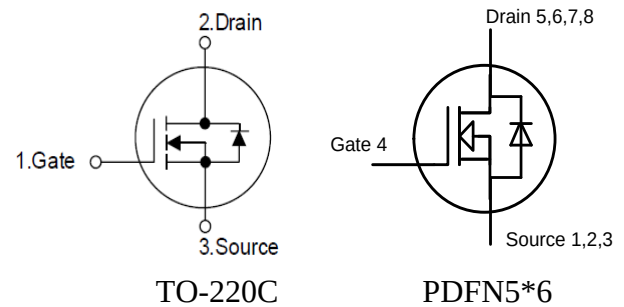
Symbol


Figure 1 Symbol of SRT15N110H

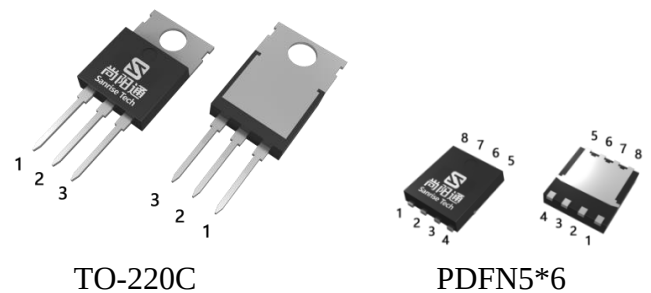
Package Type


Figure 2 Package Type of SRT15N110H

Ordering Information

Circuit Type		SRT15N110H	□	□	□
Package					
D56: PDFN5*6					
TC: TO-220C					
					E: Lead Free
					G: Green
					Blank: Tube
					TR: Tape & Reel

Package	Part Number		Marking ID		Packing Type
	Lead Free	Green	Lead Free	Green	
PDFN5*6	SRT15N110HD56TR-E	SRT15N110HD56TR-G	SRT15N110HD56E	SRT15N110HD56G	Tape & Reel
TO-220C	SRT15N110HTC-E	SRT15N110HTC-G	SRT15N110HTCE	SRT15N110HTCG	Tube

Absolute Maximum Ratings

Parameter		Symbol	Rating		Unit
Drain-Source Voltage		V _{DSS}	150		V
Gate-Source Voltage		V _{GSS}	±20		V
Continuous Drain Current, Package Limited	T _C =25°C	I _D	PDFN5*6	80	A
	T _C =100°C		TO-220C	78.5	
			PDFN5*6	56	
	Continuous Drain Current, Silicon		T _C =25°C	TO-220C	
PDFN5*6		80			
Pulsed Drain Current (Note 2)	I _{DM}	TO-220C	78.5	320	
		TO-220C	314		
Power Dissipation (T _C = 25°C)		P _D	157		W
Avalanche Destructive Energy, Single Pulse (Note 4)		E _{AS_Limit}	370		mJ
Avalanche Energy, Single Pulse (Note 3)		E _{AS}	81		mJ
Avalanche Energy, Repetitive (Note 2)		E _{AR}	0.1		mJ
Avalanche Current, Repetitive (Note 2)		I _{AR}	16		A
Continuous Diode Forward Current		I _S	80		A
Diode Pulse Current		I _{S.PULSE}	320		A
Operating Junction Temperature		T _J	175		°C
Storage Temperature		T _{STG}	-55 to 175		°C
Lead Temperature (Soldering, 10 sec)		T _{LEAD}	260		°C

Note:

1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.
2. Repetitive Rating: Pulse width limited by maximum junction temperature
3. $I_{AS} = 18\text{A}$, $V_{DD} = 60\text{V}$, $R_G = 25\Omega$, Starting $T_J = 25^\circ\text{C}$
4. $I_{AS_Limit} = 38.5\text{A}$, $V_{DD} = 60\text{V}$, $R_G = 25\Omega$, Starting $T_J = 25^\circ\text{C}$

Thermal Resistance

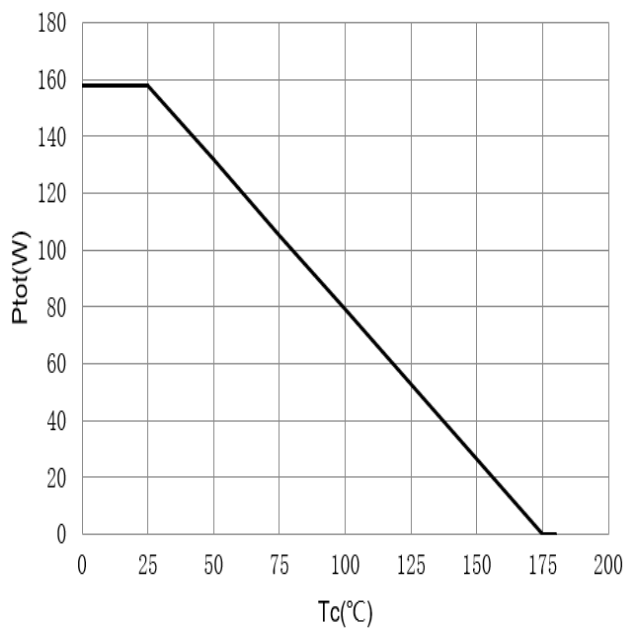
Parameter		Symbol	Min	Typ	Max	Unit
Thermal Resistance, Junction-to-Case	PDFN5*6	R_{thJC}			0.95	$^\circ\text{C/W}$
	TO-220C				0.95	
Thermal Resistance, Junction-to-Ambient	PDFN5*6	R_{thJA}			50	
	TO-220C				62	

11mΩ, 150V, N-Channel Power MOSFET
SRT15N110H
Electrical Characteristics
 $T_J = 25^{\circ}\text{C}$, unless otherwise specified.

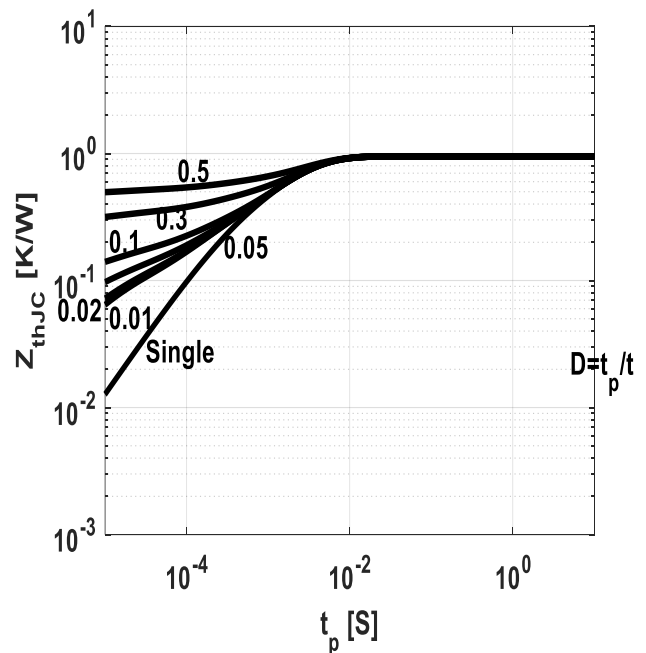
Parameter		Symbol	Test Conditions	Min	Typ	Max	Unit
Statistic Characteristics							
Drain-Source Breakdown Voltage		BV _{DSS}	V _{GS} =0V, I _D =250uA	150			V
Zero Gate Voltage Drain Current		I _{DSS}	V _{DS} =150V, V _{GS} =0V			1	uA
Gate-Body Leakage Current	Forward	I _{GSSF}	V _{GS} =20V, V _{DS} =0V			100	nA
	Reverse	I _{GSSR}	V _{GS} =-20V, V _{DS} =0V			-100	
Gate Threshold Voltage		V _{GS(TH)}	V _{DS} =V _{GS} , I _D =0.25mA	2.0	3.0	4.0	V
Static Drain-Source On-Resistance	PDFN5*6	R _{DS(ON)}	V _{GS} =10V, I _D =60A		9.1	11	mΩ
	TO-220C				10.3	12.8	
Gate Resistance		R _G	f=1MHz, Open Drain		1.1		Ω
Dynamic Characteristics							
Input Capacitance		C _{ISS}	V _{DS} =50V, V _{GS} =0V, f=1MHz		2.25		nF
Output Capacitance		C _{OSS}			1.03		nF
Reverse Transfer Capacitance		C _{RSS}			18		pF
Effective output capacitance, energy related ^{NOTE5}		C _{O(er)}	V _{GS} =0V, V _{DS} =0...90V		28		nF
Effective output capacitance, time related ^{NOTE6}		C _{O(tr)}			0.9		
Turn-on Delay Time		t _{d(on)}	V _{DD} =75V, I _D =60A R _G =1.6Ω, V _{GS} =10V		9		nS
Rise Time		t _r			3		
Turn-off Delay Time		t _{d(off)}			15		
Fall Time		t _f			3		
Gate Charge Characteristics							
Gate to Source Charge		Q _{gs}	V _{DD} =75V, I _D =60A V _{GS} =0 to 10V		12.8		nC
Gate to Drain Charge		Q _{gd}			9.4		
Gate Charge Total		Q _g			40		
Gate Plateau Voltage		V _{plateau}			4.9		V
Gate Charge Total, sync FET		Q _g	V _{DD} =0.1V, V _{GS} =0 to 10V		33.4		nC
Reverse Diode Characteristics							
Drain-Source Diode Forward Voltage		V _{SD}	V _{GS} =0V, I _{SD} =60A		0.87	1.1	V
Reverse Recovery Time		t _{rr}	V _R =75V, I _F =60A dI _F /dt=100A/us		16		nS
Reverse Recovery Charge		Q _{rr}			15		nC
Peak Reverse Recovery Current		I _{rrm}			1.2		A

Note:

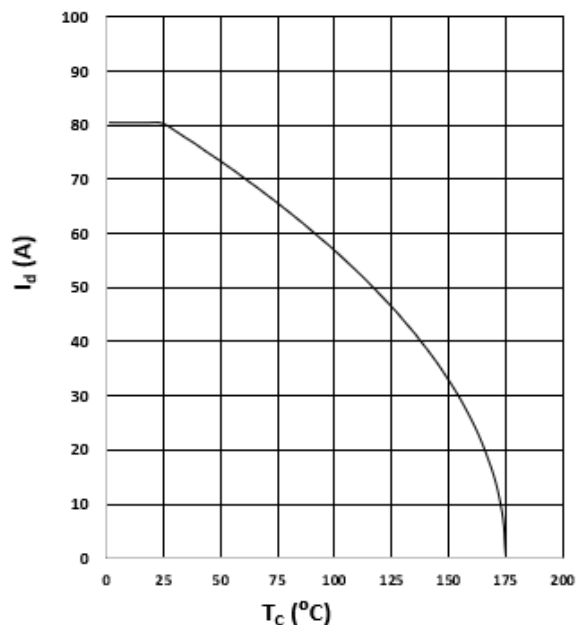
- $C_{O(er)}$ is a fixed capacitance that gives the same stored energy as C_{OSS} while V_{DS} is rising from 0 to 90V
- $C_{O(tr)}$ is a fixed capacitance that gives the same charging time as C_{OSS} while V_{DS} is rising from 0 to 90 V

Typical Performance Characteristics
Figure 3: Power Dissipation


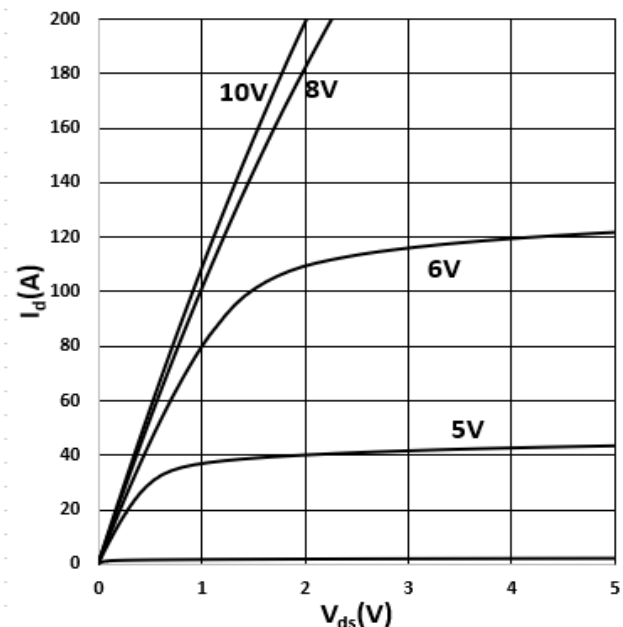
$$P_{tot}=f(T_c)$$

Figure 4: Max. Transient Thermal Impedance


$$Z_{(th)JC}=f(t_p); \text{parameter: } D=t_p/T$$

Figure5: Drain Current


$$I_D=f(T_c); V_{GS} \geq 10V$$

Figure6: Typ. Output Characteristics


$$I_D=f(V_{DS}); T_j=25^{\circ}C; \text{parameter: } V_{GS}$$

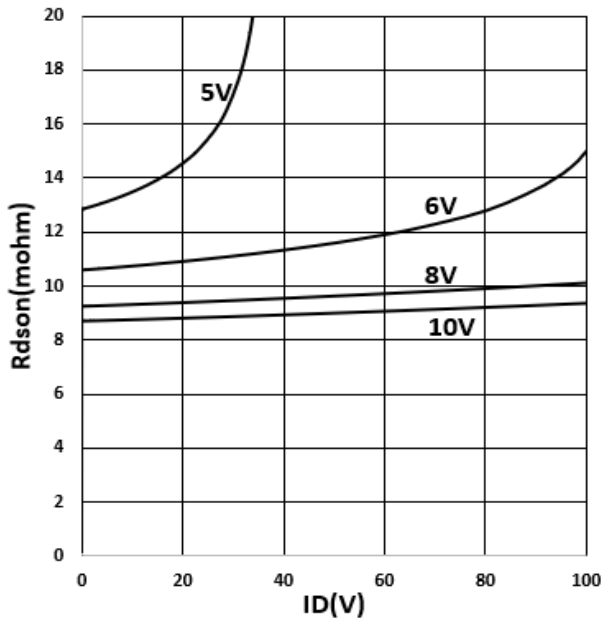
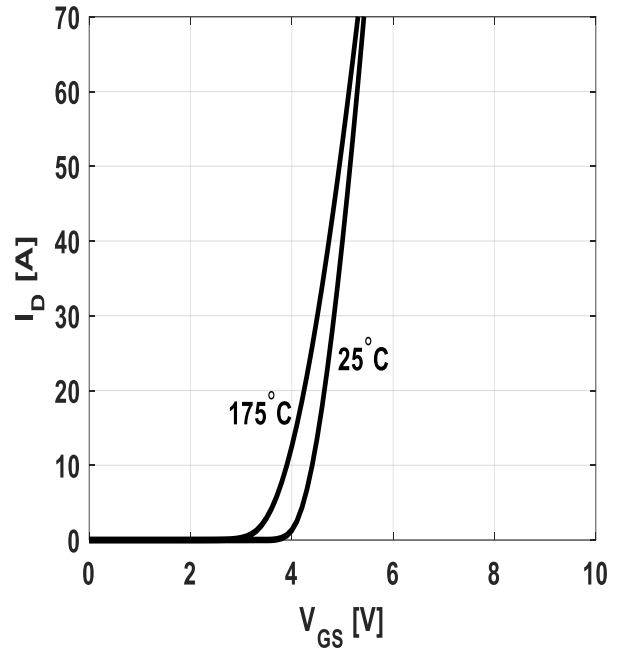
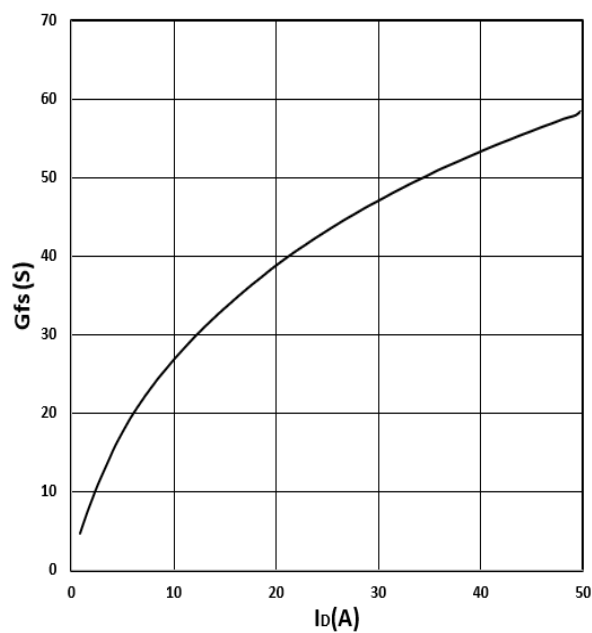
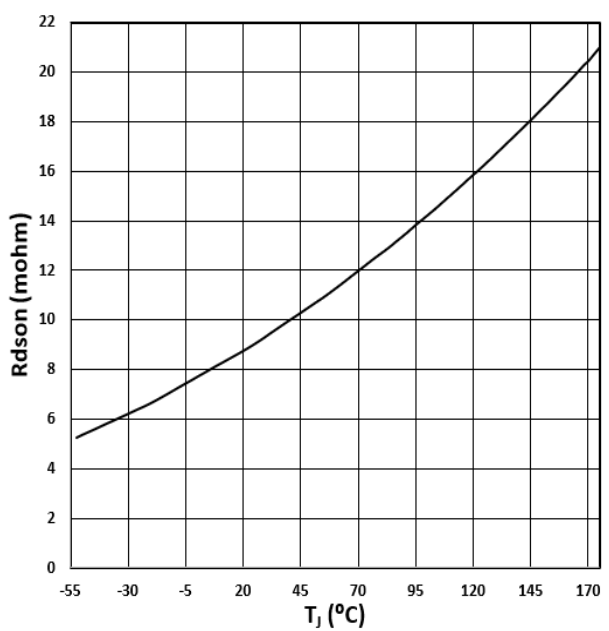
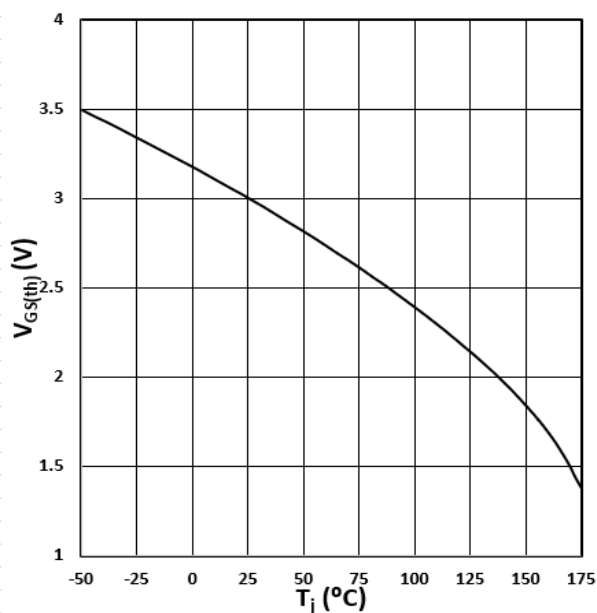
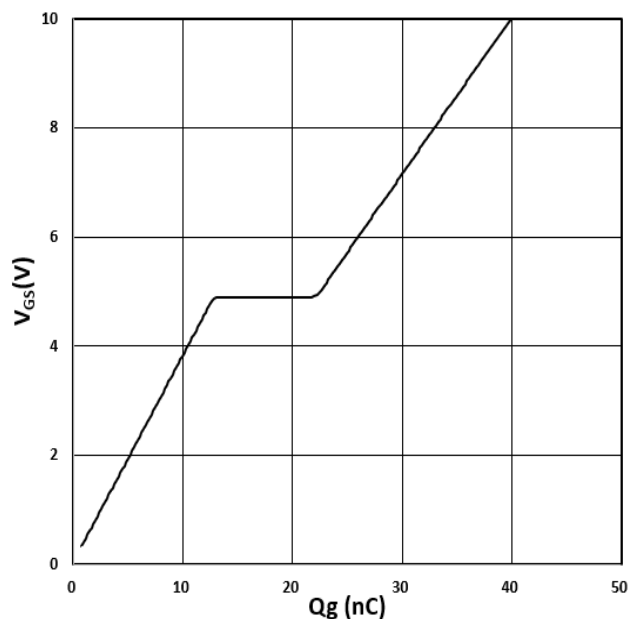
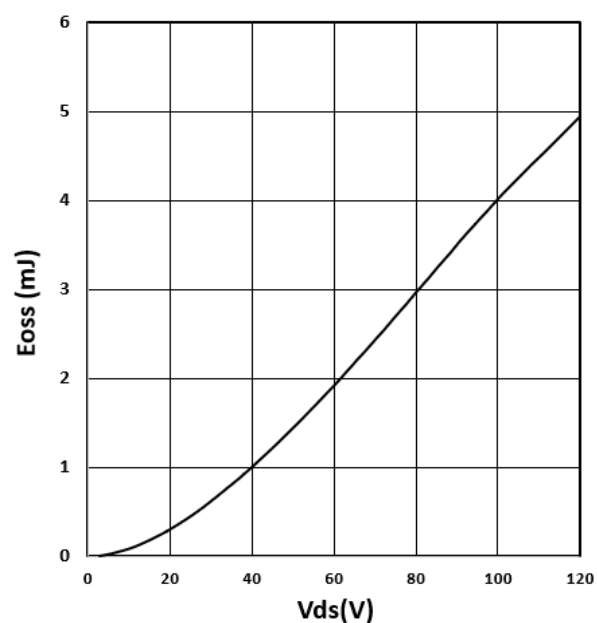
Figure7: Typ. Drain-Source On-State Resistance

 $R_{DS(ON)} = f(I_D); T_j = 25^\circ\text{C}; \text{parameter: } V_{GS}$
Figure8: Typ. Transfer Characteristics

 $I_D = f(V_{GS}); |V_{DS}| > 2|I_D|R_{DS(on)max}; \text{parameter: } T_j$
Figure9: Typ. Forward Transconductance

 $g_{fs} = f(I_D); T_j = 25^\circ\text{C}$
Figure10: Typ. Drain-Source On-State Resistance

 $R_{DS(ON)} = f(T_j); I_D = 60\text{A}; V_{GS} = 10\text{V}$

Figure11: Typ. Gate Threshold Voltage


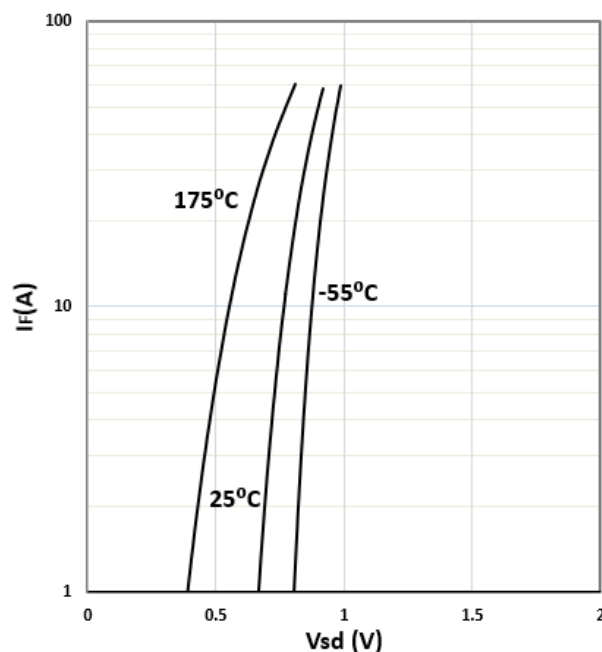
$$V_{GS(th)} = f(T_j); V_{GS} = V_{DS}; I_{DS} = 250\mu A$$

Figure 12: Typ. Gate Charge


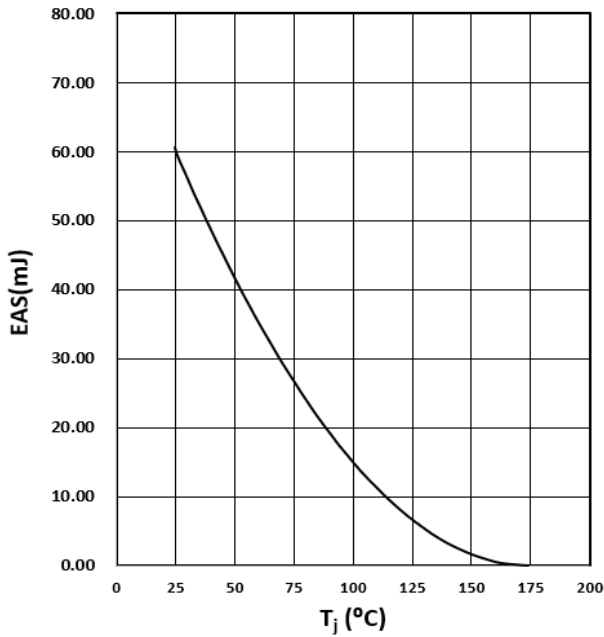
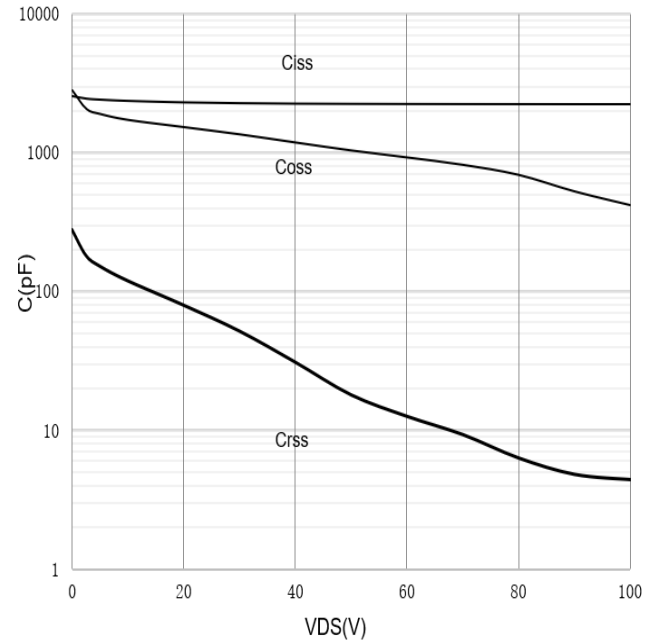
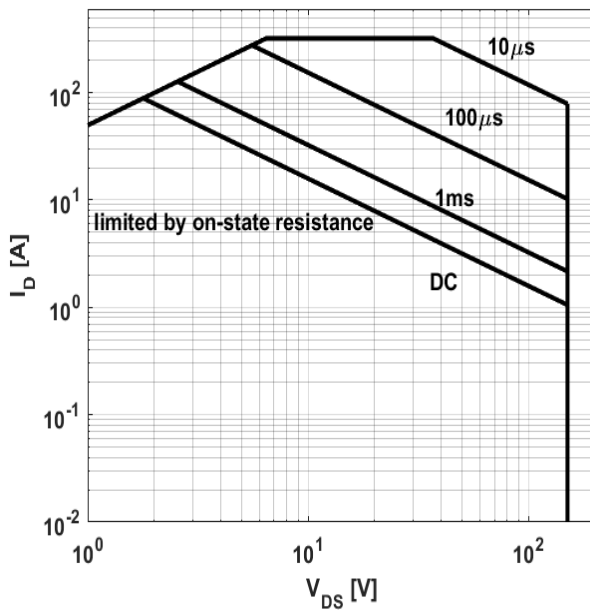
$$V_{GS} = f(Q_{gate}), I_D = 60A \text{ pulsed}$$

Figure 13: Coss Stored Energy


$$E_{OSS} = f(V_{DS})$$

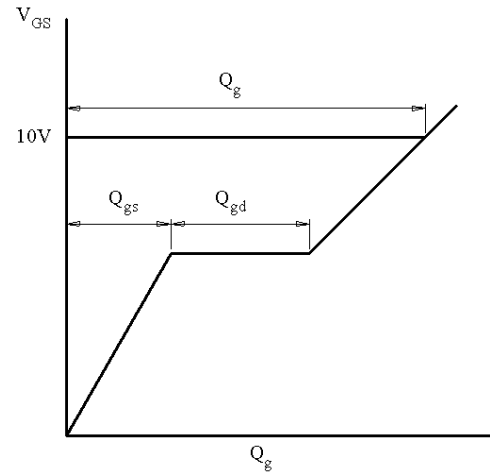
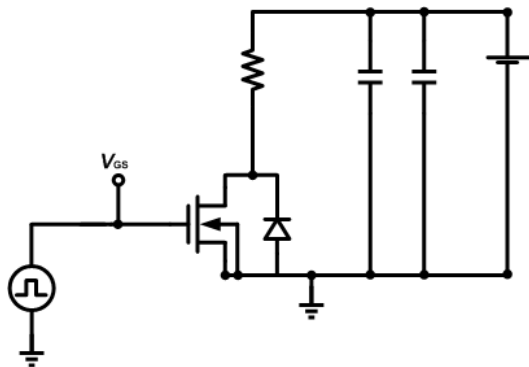
Figure 14: Forward Characteristics of Reverse Diode


$$I_F = f(V_{SD}); \text{parameter: } T_j$$

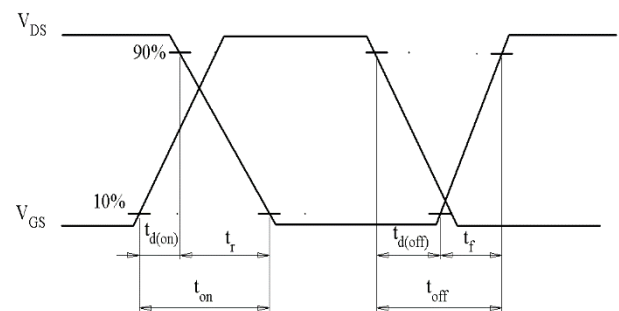
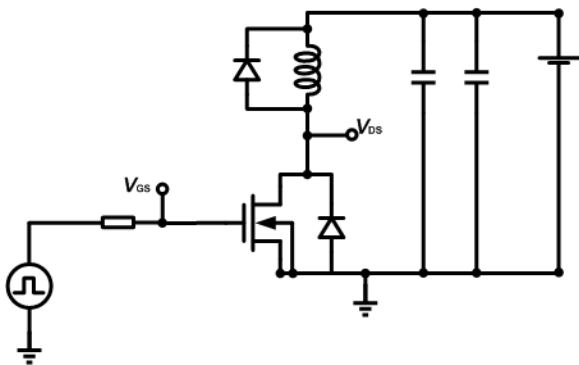
11mΩ, 150V, N-Channel Power MOSFET
SRT15N110H
Figure 15: Avalanche Energy

 $E_{AS}=f(T_j); I_D=40.0A; V_{DD}=75V$
Figure 16: Typ. Capacitances

 $C=f(V_{DS}); V_{GS}=0; f=1MHz$
Figure 17: Safe Operating Area

 $I_D = f(V_{DS}); T_c = 25^{\circ}C; V_{GS} > 7V; \text{parameter } t_p$

Test Circuits

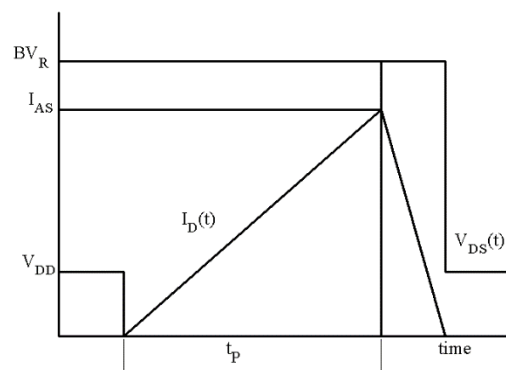
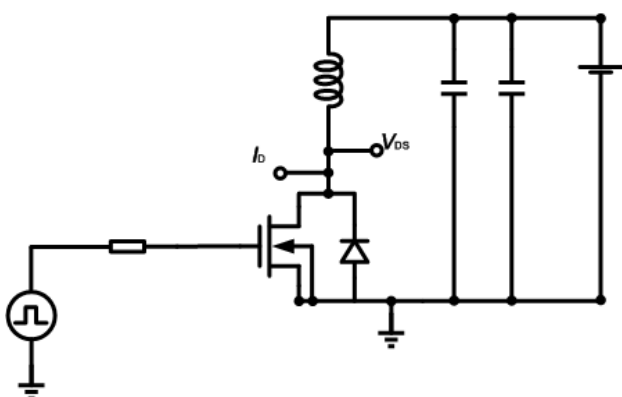
1. Gate Charge Test Circuit & Waveform



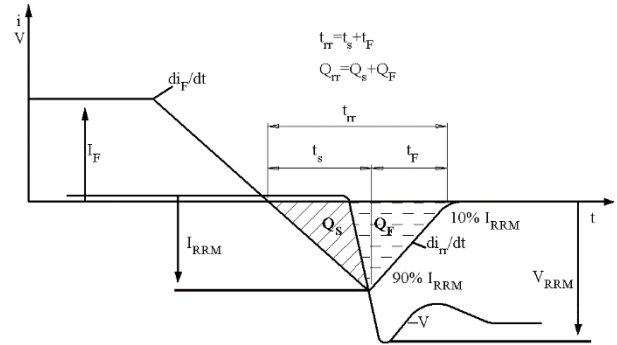
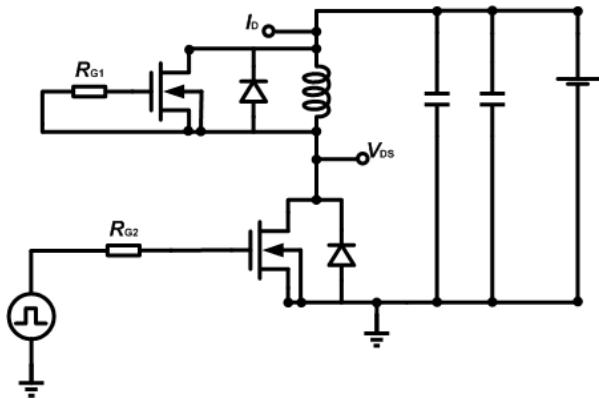
2. Switch Time Test Circuit



3. Unclamped Inductive Switching Test Circuit & Waveforms

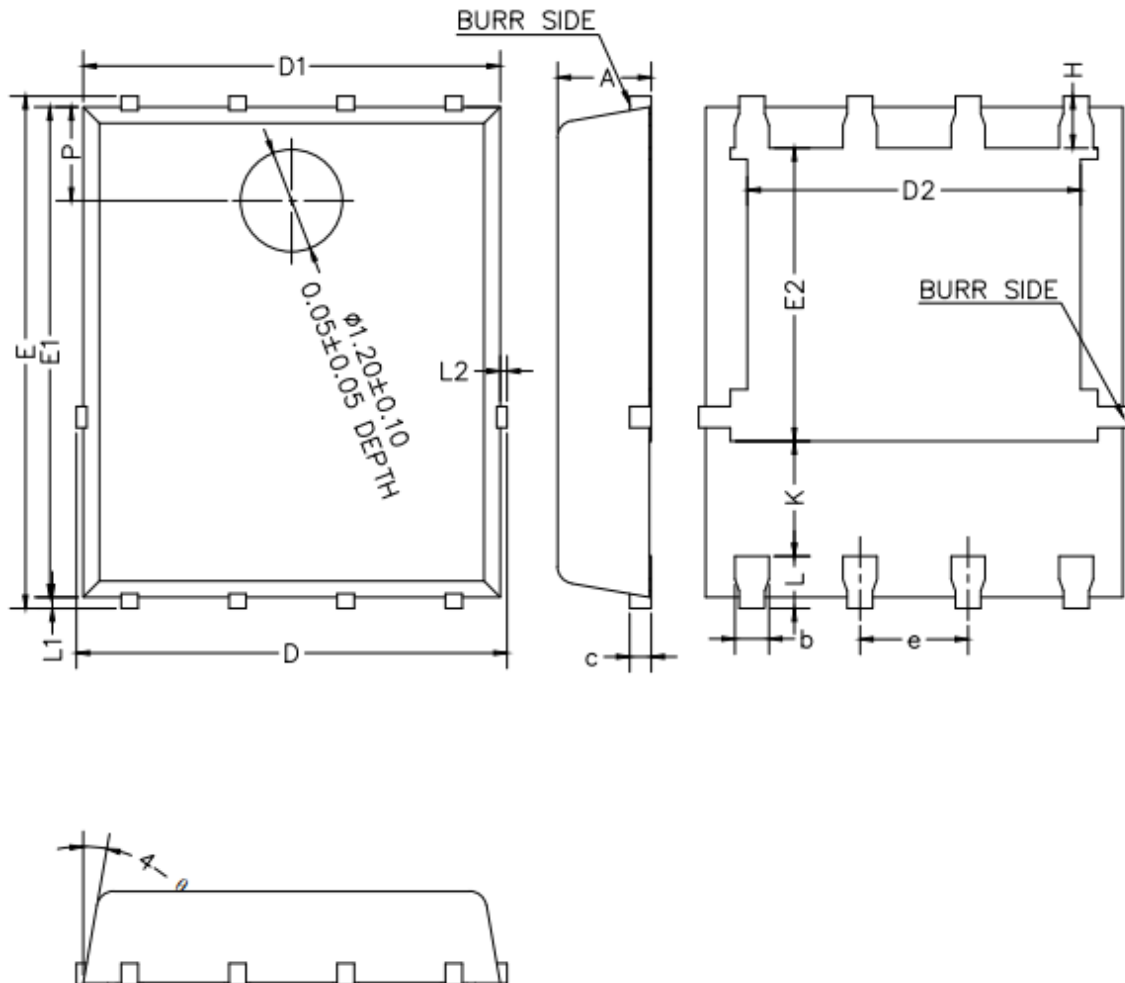


4. Test Circuit and Waveform for Diode Characteristics

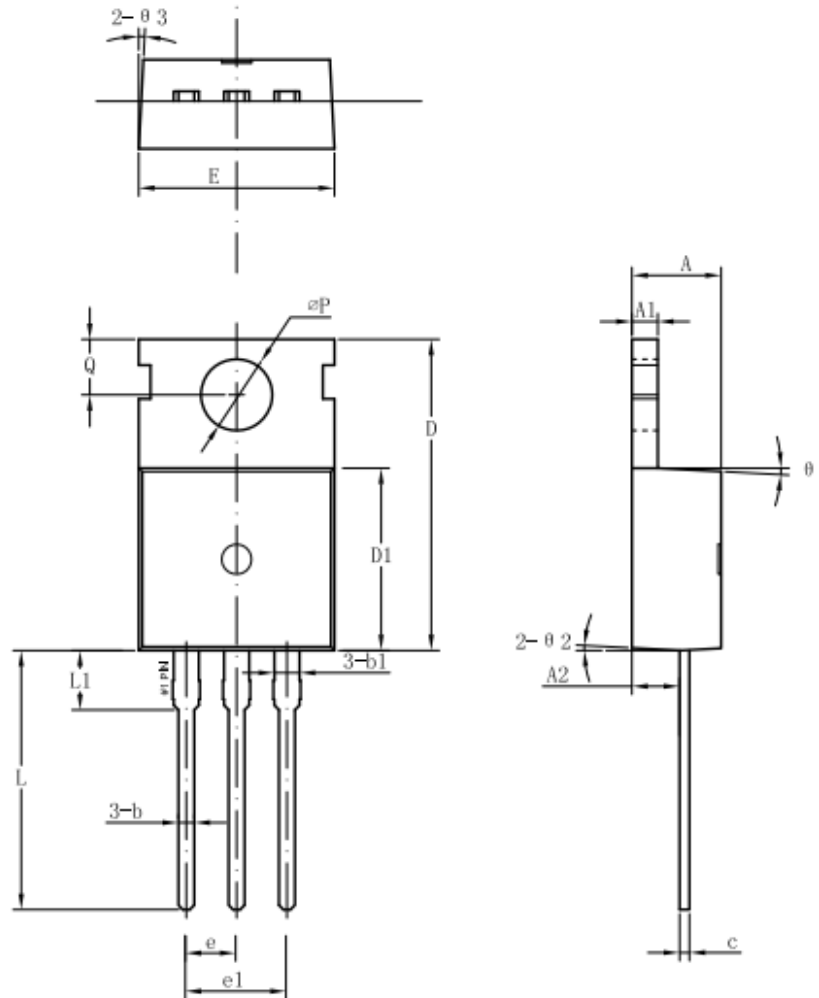


Mechanical Dimensions (Continued)

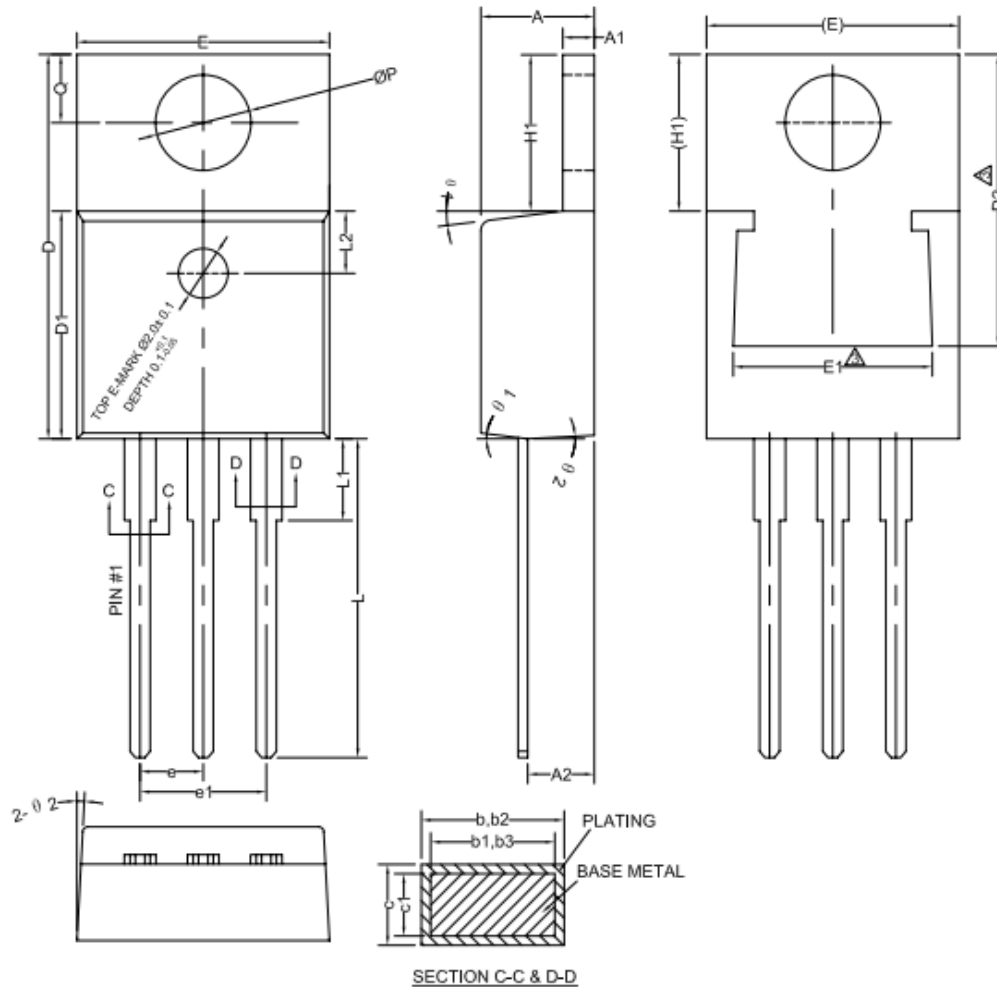
DFN5*6-8 Unit: mm



Symbol	Dimensions (mm)			Symbol	Dimensions (mm)		
	Min.	Typ.	Max.		Min.	Typ.	Max.
A	0.90	1.10	1.20	E2	3.18	—	3.54
b	0.35	0.40	0.45	H	0.51	0.61	0.71
c	0.21	0.25	0.34	K	1.10	—	—
D	—	—	5.10	L	0.51	0.61	0.71
D1	4.80	4.90	5.00	L1	0.06	0.13	0.20
D2	3.82	—	4.11	L2	—	—	0.10
e	1.17	1.27	1.37	P	1.00	1.10	1.20
E	5.90	6.00	6.10	θ	8°	10°	12°
E1	5.70	5.75	5.80				

Mechanical Dimensions
TO-220C(Package1)
Unit: mm


Symbol	Dimensions (mm)			Symbol	Dimensions (mm)		
	Min.	Typ.	Max.		Min.	Typ.	Max.
A	4.30	4.50	4.70	e	—	2.54	—
A1	1.25	1.30	1.40	e1	—	5.08	—
A2	2.20	2.40	2.60	L	12.60	13.08	13.60
b	0.70	0.80	0.95	L1	—	3.00	—
b1	—	1.27	—	ΦP	3.50	3.60	3.80
c	0.40	0.50	0.65	Q	2.60	2.80	3.00
D	15.20	15.70	16.20	θ1	—	3°	—
D1	9.00	9.20	9.40	θ2	—	3°	—
E	9.70	10.00	10.10	θ3	—	3°	—

Mechanical Dimensions
TO-220C(Package2)
Unit: mm


Symbol	Dimensions (mm)			Symbol	Dimensions (mm)		
	Min.	Typ.	Max.		Min.	Typ.	Max.
A	4.40	4.57	4.70	E	9.96	10.16	10.36
A1	1.22	—	1.32	E1	6.86	—	8.89
A2	2.59	2.69	2.79	e	2.44	2.54	2.64
b	0.77	—	0.90	e1	4.98	5.08	5.18
b1	0.76	0.81	0.86	H1	6.10	6.30	6.50
b2	1.23	—	1.36	L	12.70	—	13.12
b3	1.22	1.27	1.32	L1	—	—	3.90
c	0.34	—	0.47	L2	—	2.50REF	—
c1	0.33	0.38	0.43	ØP	3.80	3.84	3.88
D	15.15	15.45	15.75	Q	2.60	—	2.90
D1	9.05	9.15	9.25	θ 1	5°	7°	9°
D2	11.40	—	12.88	θ 2	1°	3°	5°



Sanrise Technology Limited Company

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